

June 2000

# **FQP1P50**

### **500V P-Channel MOSFET**

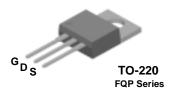
### **General Description**

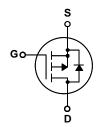
These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for electronic lamp ballast based on complementary half bridge.

### **Features**

- -1.5A, -500V,  $R_{DS(on)}$  = 10.5 $\Omega$  @V<sub>GS</sub> = -10 V Low gate charge ( typical 11 nC)
- Low Crss (typical 6.0 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability





## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQP1P50	Units
V <sub>DSS</sub>	Drain-Source Voltage		-500	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)		-1.5	А
	- Continuous (T <sub>C</sub> = 100°C)		-0.95	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	-6.0	А
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	110	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	-1.5	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	6.3	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-4.5	V/ns
$P_D$	Power Dissipation (T <sub>C</sub> = 25°C)		63	W
	- Derate above 25°C		0.51	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

### **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		1.98	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics				•	•
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-500			V
$\Delta BV_{DSS}$ / $\Delta T_{.1}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu\text{A}$ , Referenced to 25°C		-		V/°C
I <sub>DSS</sub>		V <sub>DS</sub> = -500 V, V <sub>GS</sub> = 0 V			-1	μА
	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -400 V, T <sub>C</sub> = 125°C			-10	μA
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V			-100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V			100	nA
	aracteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-3.0		-5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -0.75 \text{ A}$		8.0	10.5	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = -50 \text{ V}, I_D = -0.75 \text{ A}$ (Note 4)		1.26		S
C <sub>iss</sub>	Input Capacitance Output Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0  MHz		270 40	350 50	pF pF
C <sub>rss</sub>	Reverse Transfer Capacitance			6.0	8.0	pF
Switchi	ing Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = -250 V, I <sub>D</sub> = -1.5 A,		9.0	30	ns
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25 \Omega$		25	60	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	1.6 - 20 22		27	65	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)		30	70	ns
Qg	Total Gate Charge	V <sub>DS</sub> = -400 V, I <sub>D</sub> = -1.5 A,		11	14	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = -10 V		2.0		nC
Q <sub>gd</sub>	Gate-Drain Charge	(Note 4, 5)		5.6		nC
Drain-S	Source Diode Characteristics at Maximum Continuous Drain-Source Dio				-1.5	А
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode F	Source Diode Forward Current			-6.0	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -1.5 \text{ A}$			-5.0	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_S = -1.5 \text{ A},$		200		ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F / dt = 100 \text{ A/}\mu\text{s}$ (Note 4)		0.7		μС

- Notes: 1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 88mH,  $I_{AS}$  = -1.5A,  $V_{DD}$  = -50V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C 3.  $I_{SD}$   $\leq$  -1.5A, di/dt  $\leq$  200A/ $\mu$ s,  $V_{DD}$   $\leq$  BV $_{DSS}$ , Starting  $T_{J}$  = 25°C 4. Pulse Test : Pulse width  $\leq$  300 $\mu$ s, Duty cycle  $\leq$  2% 5. Essentially independent of operating temperature

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# **Typical Characteristics**

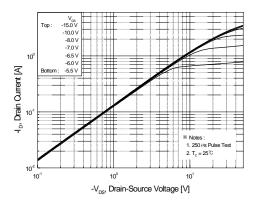


Figure 1. On-Region Characteristics

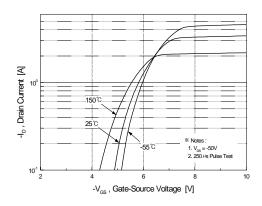


Figure 2. Transfer Characteristics

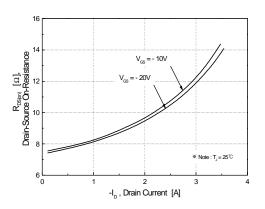


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

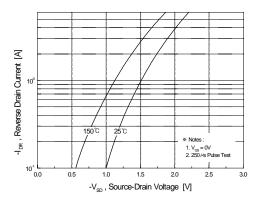


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

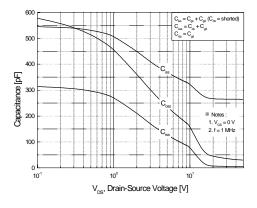


Figure 5. Capacitance Characteristics

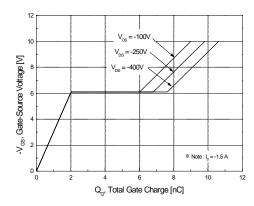
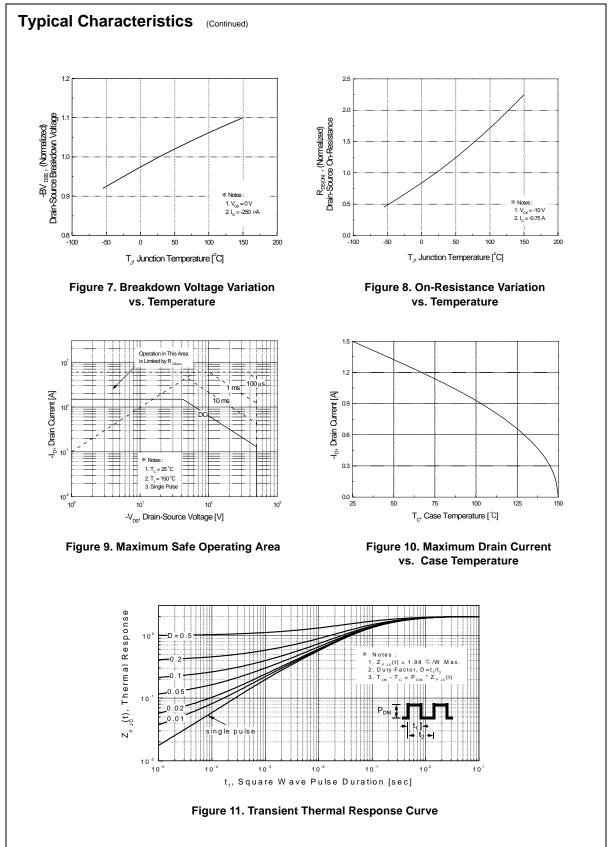


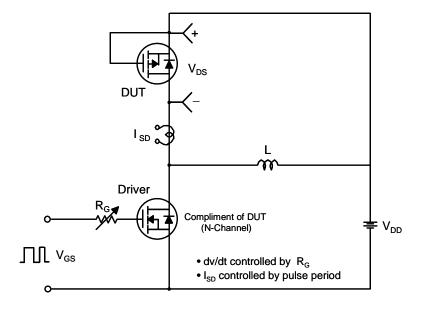
Figure 6. Gate Charge Characteristics

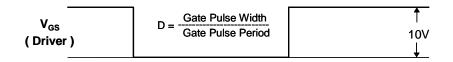


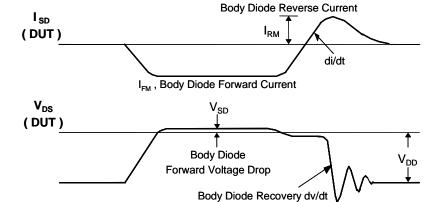
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# **Gate Charge Test Circuit & Waveform** $V_{\text{GS}}$ Same Type as DUT -10V DUT Charge **Resistive Switching Test Circuit & Waveforms** DUT -10V ∐ **Unclamped Inductive Switching Test Circuit & Waveforms** Time $V_{DS}(t)$ DUT IAS $\mathsf{BV}_{\mathsf{DSS}}$

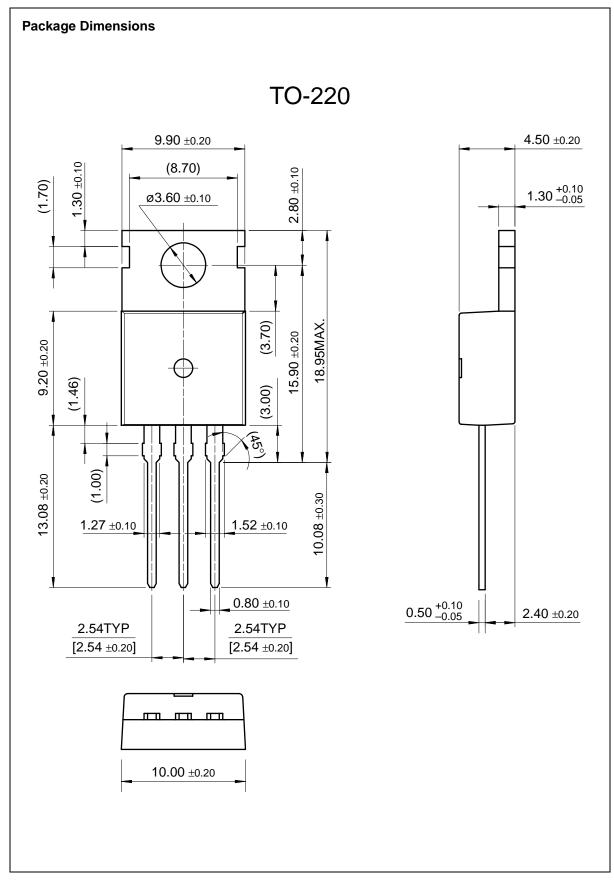
### Peak Diode Recovery dv/dt Test Circuit & Waveforms







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